

# March 2013

# **FDP24N40**

# N-Channel UniFET<sup>TM</sup> MOSFET 400 V, 24 A, 175 m $\Omega$

# **Features**

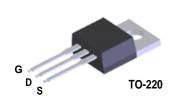
- $R_{DS(on)}$  = 140 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 12 A
- Low Gate Charge (Typ. 46 nC)
- Low C<sub>rss</sub> (Typ. 25 pF)
- 100% Avalanche Tested
- · RoHS Compliant

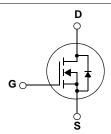
# **Applications**

- Uninterruptible Power Supply
- AC-DC Power Supply

# **Description**

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor<sup>®</sup>s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





# **MOSFET Maximum Ratings** T<sub>C</sub> = 25°C unless otherwise noted

|                                   | •  | ·                                     |                   |             |      |
|-----------------------------------|--|---------------------------------------|-------------------|-------------|------|
| Symbol                            |  | Parameter                             |                   | FDP24N40    | Unit |
| V <sub>DSS</sub>                  | Drain to Source Voltage                              | Drain to Source Voltage               |                   | 400         | V    |
| V <sub>GSS</sub>                  | Gate to Source Voltage                               |                                       |                   | ±30         | V    |
|                                   | Drain Current  | - Continuous (T <sub>C</sub> = 25°C)  |                   | 24          | ^    |
| I <sub>D</sub>                    | DrainCurrent   | - Continuous (T <sub>C</sub> = 100°C) |                   | 14.4        | Α    |
| I <sub>DM</sub>                   | Drain Current  | - Pulsed                              | - Pulsed (Note 1) |             | Α    |
| E <sub>AS</sub>                   | Single Pulsed Avalanche Er                           | nergy                                 | (Note 2)          | 1296        | mJ   |
| I <sub>AR</sub>                   | Avalanche Current                                    |                                       | (Note 1)          | 24          | Α    |
| E <sub>AR</sub>                   | Repetitive Avalanche Energ                           | у                                     | (Note 1)          | 22.7        | mJ   |
| dv/dt                             | Peak Diode Recovery dv/dt                            |                                       | (Note 3)          | 4.5         | V/ns |
| D                                 | Davies Dissination                                   | $(T_C = 25^{\circ}C)$                 |                   | 227         | W    |
| $P_{D}$                           | Power Dissipation                                    | - Derate above 25°C                   |                   | 1.8         | W/°C |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Tem                            | perature Range                        |                   | -55 to +150 | °C   |
| T <sub>L</sub>                    | Maximum Lead Temperature 1/8" from Case for 5 Second | • •                                   |                   | 300         | °C   |

<sup>\*</sup>Drain current limited by maximum junction temperature

# **Thermal Characteristics**

| Symbol          | Parameter                                     | FDP24N40 | Unit |
|-----------------|---|----------|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max.    | 0.55     |      |
| $R_{\theta CS}$ | Thermal Resistance, Case to Sink, Typ.        | 0.5      | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 62.5     |      |

# Package Marking and Ordering Information $T_C = 25$ °C unless otherwise noted

| Device Marking | Device   | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|---------|-----------|------------|----------|
| FDP24N40       | FDP24N40 | TO-220  | -         | -          | 50       |

# **Electrical Characteristics**

| Symbol                                  | Parameter                                 | Test Conditions                                  | Min. | Тур. | Max. | Unit |
|---|---|--|------|------|------|------|
| Off Chara                               | cteristics                                |  |      |      |      |      |
| BV <sub>DSS</sub>                       | Drain to Source Breakdown Voltage         | $I_D = 250\mu A, V_{GS} = 0V, T_J = 25^{\circ}C$ | 400  | -    | -    | V    |
| ΔBV <sub>DSS</sub><br>/ ΔΤ <sub>J</sub> | Breakdown Voltage Temperature Coefficient | I <sub>D</sub> = 250μA, Referenced to 25°C       | -    | 0.4  | -    | V/°C |
| 1                                       | Zero Gate Voltage Drain Current           | $V_{DS} = 400V, V_{GS} = 0V$                     | -    | -    | 1    | μА   |
| IDSS                                    | Zero Gate voltage Drain Current           | $V_{DS} = 320V, T_{C} = 125^{\circ}C$            | -    | -    | 10   | μΑ   |
| I <sub>GSS</sub>                        | Gate to Body Leakage Current              | $V_{GS} = \pm 30V, V_{DS} = 0V$                  | -    | -    | ±100 | nA   |

### On Characteristics

| V <sub>GS(th)</sub> | Gate Threshold Voltage               | $V_{GS} = V_{DS}, I_{D} = 250 \mu A$ | 3.0 | -     | 5.0   | V |
|---------------------|--------------------------------------|--------------------------------------|-----|-------|-------|---|
| R <sub>DS(on)</sub> | Static Drain to Source On Resistance | $V_{GS} = 10V, I_D = 12A$            | -   | 0.140 | 0.175 | Ω |
| 9 <sub>FS</sub>     | Forward Transconductance             | $V_{DS} = 20V, I_{D} = 12A$          | -   | 34    | -     | S |

# **Dynamic Characteristics**

| C <sub>iss</sub>    | Input Capacitance             | V 05V V 0V                              |          | = | 2270 | 3020 | pF |
|---------------------|-------------------------------|---|----------|---|------|------|----|
| C <sub>oss</sub>    | Output Capacitance            | $V_{DS} = 25V, V_{GS} = 0V$<br>f = 1MHz |          | - | 365  | 490  | pF |
| C <sub>rss</sub>    | Reverse Transfer Capacitance  | 1 - 111112                              |          | - | 25   | 38   | pF |
| Q <sub>g(tot)</sub> | Total Gate Charge at 10V      |   |          | - | 46   | 60   | nC |
| Q <sub>gs</sub>     | Gate to Source Gate Charge    | $V_{DS} = 320V, I_{D} = 24A$            |          | - | 12   | -    | nC |
| $Q_{gd}$            | Gate to Drain "Miller" Charge | V <sub>GS</sub> = 10V                   | (Note 4) | - | 20   | -    | nC |

# **Switching Characteristics**

| t <sub>d(on)</sub>  | Turn-On Delay Time  |                              | - | 40  | 90  | ns |
|---------------------|---------------------|------------------------------|---|-----|-----|----|
| t <sub>r</sub>      | Turn-On Rise Time   | $V_{DD} = 200V, I_{D} = 24A$ | - | 90  | 190 | ns |
| t <sub>d(off)</sub> | Turn-Off Delay Time | $R_G = 25\Omega$             | - | 110 | 230 | ns |
| t <sub>f</sub>      | Turn-Off Fall Time  | (Note 4)                     | - | 65  | 140 | ns |

## **Drain-Source Diode Characteristics**

| I <sub>S</sub>  | Maximum Continuous Drain to Source Diode Forward Current |   | - | -   | 24  | Α  |
|-----------------|--|---|---|-----|-----|----|
| I <sub>SM</sub> | Maximum Pulsed Drain to Source Diode Forward Current     |   | - | -   | 96  | Α  |
| $V_{SD}$        | Drain to Source Diode Forward Voltage                    | $V_{GS} = 0V, I_{SD} = 24A$                 | - | -   | 1.4 | V  |
| t <sub>rr</sub> | Reverse Recovery Time                                    | V <sub>GS</sub> = 0V, I <sub>SD</sub> = 24A | - | 360 | -   | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge                                  | $dI_F/dt = 100A/\mu s$                      | - | 4.7 | -   | μC |

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 4.5mH,  $I_{AS}$  = 24A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25°C
- 3.  $I_{SD} \le 24 A$ , di/dt  $\le 200 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25 ^{\circ} C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

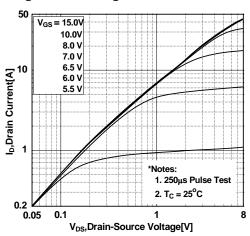


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

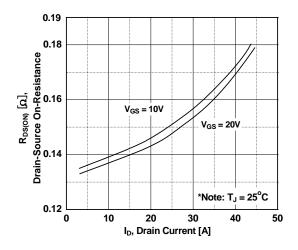


Figure 5. Capacitance Characteristics

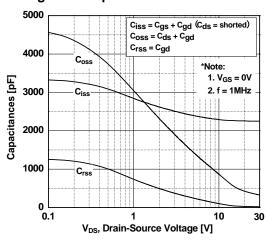


Figure 2. Transfer Characteristics

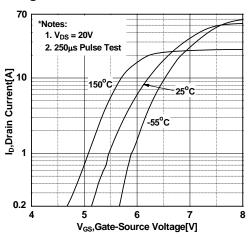


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

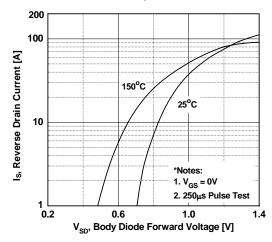
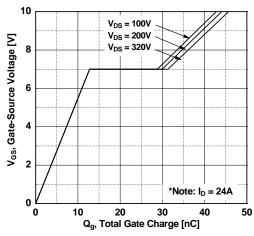


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics (Continued)**

Figure 7. Breakdown Voltage Variation vs. Temperature

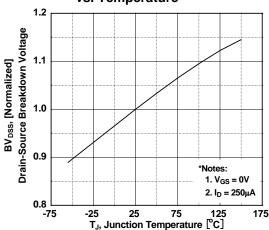


Figure 8. On-Resistance Variation vs. Temperature

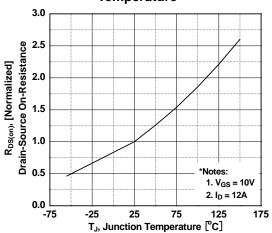


Figure 9. Maximum Safe Operating Area

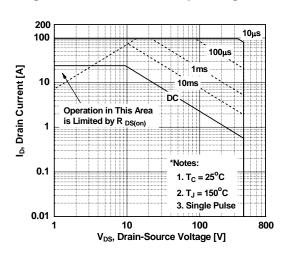


Figure 10. Maximum Drain Current vs. Case Temperature

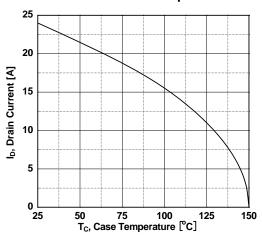
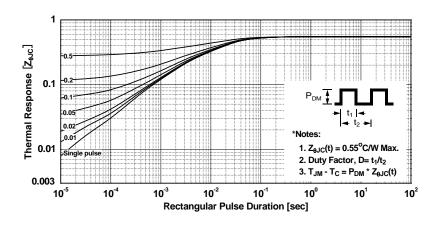
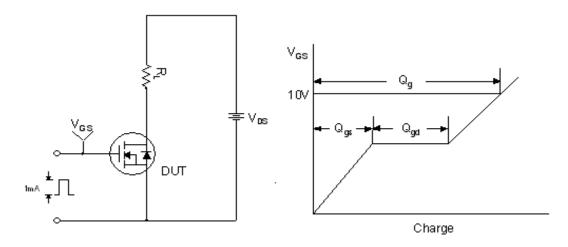


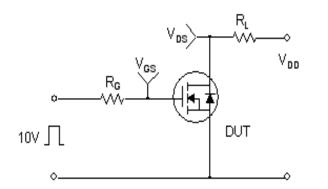
Figure 10. Transient Thermal Response Curve

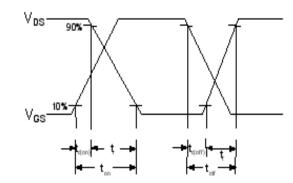


# **Gate Charge Test Circuit & Waveform**

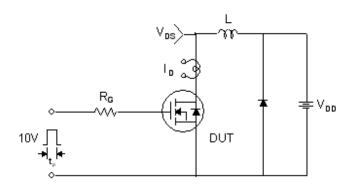


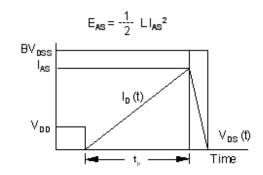
## **Resistive Switching Test Circuit & Waveforms**



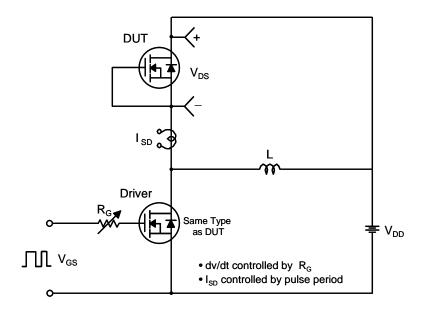


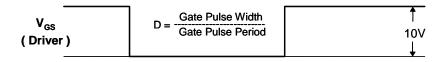
**Unclamped Inductive Switching Test Circuit & Waveforms** 

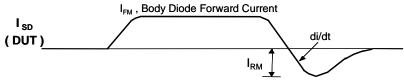




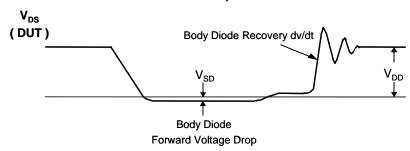
## Peak Diode Recovery dv/dt Test Circuit & Waveforms





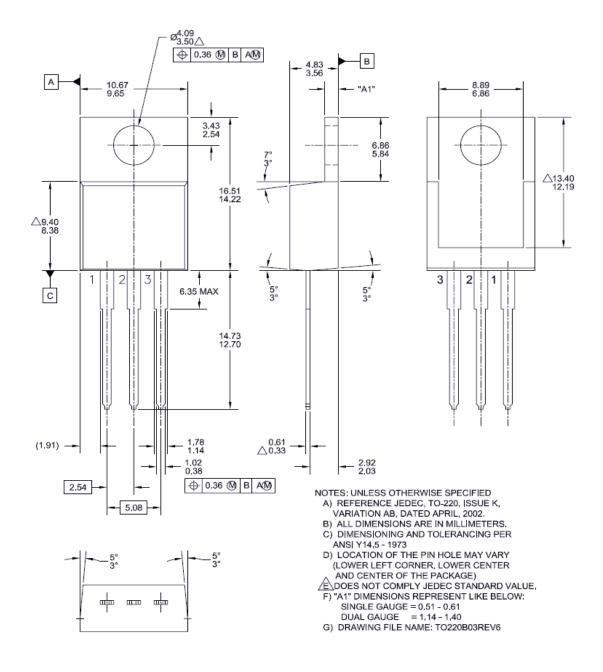


Body Diode Reverse Current



# **Mechanical Dimensions**

# TO-220B03







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